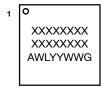


DATE 09 JAN 2009

- NOTES:
 1. DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
 CONTROLLING DIMENSIONS: MILLIMETERS.
- DIMENSION 6 APPLIES TO PLATED
 TERMINAL AND IS MEASURED BETWEEN
- 1EHMINAL AND IS MEASURED BE I WEEN 0.15 AND 0.30mm FROM TERMINAL COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS. POSITIONAL TOLERANCE APPLIES TO ALL THREE EXPOSED PADS.

	MILLIMETERS		
DIM	MIN	MAX	
Α	0.80	1.00	
A1	-	0.05	
A3	0.20 REF		
b	0.18	0.30	
D	6.00 BSC		
D2	2.30	2.50	
D3	1.40	1.60	
E	6.00 BSC		
E2	4.30	4.50	
E3	1.90	2.10	
е	0.50 BSC		
G	2.20 BSC		
K	0.20	-	
L	0.30	0.50	
L1		0.15	

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code

= Assembly Location

= Wafer Lot WL ΥY = Year WW = Work Week = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking.

Pb-Free indicator, "G" or microdot " ■", may or may not be present.

DOCUMENT NUMBER:		Printed versions are uncontrolled except when stamped "CONTROLLED"	
DESCRIPTION	OEN/0.6v6 0.5D		DAGE 1 OF 1
DESCRIPTION:	QFN40 6x6. 0.5P		PAGE 1 OF 1

DIMENSIONS: MILLIMETERS

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0.50 -**PITCH**

2.16

PKG OUTLINE